

Silicon Controlled Rectifiers

Reverse Blocking Thyristors

Designed primarily for half-wave ac control applications, such as motor controls, heating controls and power supplies; or wherever half-wave silicon gate-controlled, solid-state devices are needed.

- Glass Passivated Junctions with Center Gate Geometry for Greater Parameter Uniformity and Stability
- Small, Rugged, Thermowatt Construction for Low Thermal Resistance, High Heat Dissipation and Durability
- Blocking Voltage to 800 Volts
- Device Marking: Logo, Device Type, e.g., 2N6400, Date Code

*MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off-State Voltage (Note 1.) ($T_J = -40$ to 125°C , Sine Wave 50 to 60 Hz; Gate Open)	V_{DRM} , V_{RRM}		Volts
2N6400		50	
2N6401		100	
2N6402		200	
2N6403		400	
2N6404		600	
2N6405		800	
On-State RMS Current (180° Conduction Angles; $T_C = 100^\circ\text{C}$)	$I_{T(RMS)}$	16	A
Average On-State Current (180° Conduction Angles; $T_C = 100^\circ\text{C}$)	$I_{T(AV)}$	10	A
Peak Non-repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, $T_J = 90^\circ\text{C}$)	I_{TSM}	160	A
Circuit Fusing ($t = 8.3$ ms)	I^2t	145	A^2s
Forward Peak Gate Power (Pulse Width ≤ 1.0 μs , $T_C = 100^\circ\text{C}$)	P_{GM}	20	Watts
Forward Average Gate Power ($t = 8.3$ ms, $T_C = 100^\circ\text{C}$)	$P_{G(AV)}$	0.5	Watts
Forward Peak Gate Current (Pulse Width ≤ 1.0 μs , $T_C = 100^\circ\text{C}$)	I_{GM}	2.0	A
Operating Junction Temperature Range	T_J	-40 to +125	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	-40 to +150	$^\circ\text{C}$

*Indicates JEDEC Registered Data.

1. V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

2N6400 Series

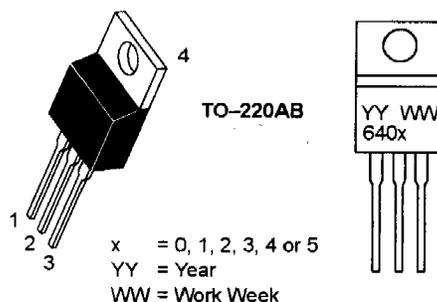
SCRs

16 AMPERES RMS

50 thru 800 VOLTS

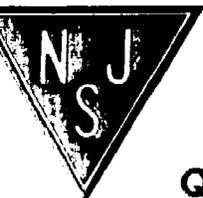


MARKING
DIAGRAM



PIN ASSIGNMENT

Pin Number	Assignment
1	Cathode
2	Anode
3	Gate
4	Anode



NJ Semi-Conductors reserves the right to change test conditions, parameters limits and package dimensions without notice information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

Quality Semi-Conductors

2N6400 Series

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	1.5	C/W
Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 10 Seconds	T_L	260	C

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

*Peak Repetitive Forward or Reverse Blocking Current ($V_{AK} = \text{Rated } V_{DRM} \text{ or } V_{RRM}, \text{ Gate Open}$)	I_{DRM}, I_{RRM}	-	-	10	μA
$T_J = 25^\circ\text{C}$					
				2.0	mA

ON CHARACTERISTICS

*Peak Forward On-State Voltage ($I_{TM} = 32 \text{ A Peak, Pulse Width } \leq 1 \text{ ms, Duty Cycle } \leq 2\%$)	V_{TM}	-	-	1.7	Volts
*Gate Trigger Current (Continuous dc) ($V_D = 12 \text{ Vdc, } R_L = 100 \text{ Ohms}$)	I_{GT}	-	-	9.0	mA
$T_C = 25^\circ\text{C}$				30	
				60	
*Gate Trigger Voltage (Continuous dc) ($V_D = 12 \text{ Vdc, } R_L = 100 \text{ Ohms}$)	V_{GT}	-	-	0.7	Volts
$T_C = 25^\circ\text{C}$				1.5	
				2.5	
Gate Non-Trigger Voltage ($V_D = 12 \text{ Vdc, } R_L = 100 \text{ Ohms}$)	V_{GD}	0.2	-	-	Volts
*Holding Current ($V_D = 12 \text{ Vdc, Initiating Current} = 200 \text{ mA, Gate Open}$)	I_H	-	-	18	mA
$T_C = 25^\circ\text{C}$				40	
				60	
Turn-On Time ($I_{TM} = 16 \text{ A, } I_{GT} = 40 \text{ mAdc, } V_D = \text{Rated } V_{DRM}$)	t_{gt}	-	1.0	-	μs
Turn-Off Time ($I_{TM} = 16 \text{ A, } I_R = 16 \text{ A, } V_D = \text{Rated } V_{DRM}$)	t_q	-	-	15	μs
$T_C = 25^\circ\text{C}$				-	
				35	

DYNAMIC CHARACTERISTICS

Critical Rate-of-Rise of Off-State Voltage ($V_D = \text{Rated } V_{DRM}, \text{ Exponential Waveform}$)	dv/dt	-	50	-	$\text{V}/\mu\text{s}$

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